

SLPS271G -JULY 2010-REVISED SEPTEMBER 2012

30V, N-Channel NexFET™ Power MOSFETs

Check for Samples: CSD17510Q5A

FEATURES

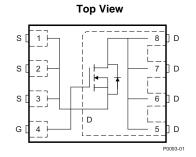
- Ultralow Q_g and Q_{gd}
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- RoHS Compliant
- Halogen Free
- SON 5-mm × 6-mm Plastic Package

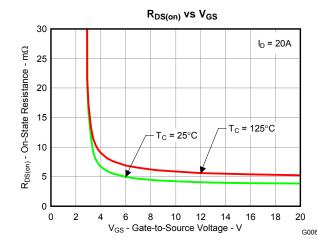
APPLICATIONS

- Point-of-Load Synchronous Buck in Networking, Telecom, and Computing Systems
- Optimized for Control and Synchronous FET
 Applications

DESCRIPTION

The NexFET[™] power MOSFET has been designed to minimize losses in power conversion applications.





PRODUCT SUMMARY

V _{DS}	Drain to Source Voltage	30	V	
Qg	Gate Charge Total (4.5V) 6.4			nC
Q _{gd}	Gate Charge Gate to Drain	1.9	nC	
D	Drain to Source On Resistance	$V_{GS} = 4.5V$	5.4	mΩ
R _{DS(on)}	Drain to Source On Resistance	V _{GS} = 10V 4.1		mΩ
V _{GS(th)}	Threshold Voltage 1.5			V

ORDERING INFORMATION

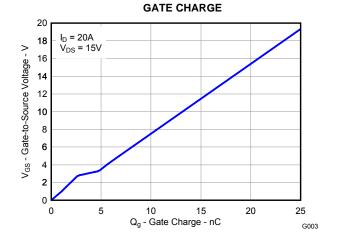
Device	Package	Media	Qty	Ship
CSD17510Q5A	SON 5-mm × 6-mm Plastic Package	13-Inch Reel	2500	Tape and Reel

ABSOLUTE MAXIMUM RATINGS

$T_A = 2$	5°C unless otherwise stated	VALUE	UNIT
V _{DS}	Drain to Source Voltage	30	V
V_{GS}	Gate to Source Voltage	±20	V
	Continuous Drain Current, $T_C = 25^{\circ}C$	55	А
ID	Continuous Drain Current ⁽¹⁾	20	А
I _{DM}	Pulsed Drain Current, $T_A = 25^{\circ}C^{(2)}$	129	А
PD	Power Dissipation ⁽¹⁾	3	W
T _J , T _{STG}	Operating Junction and Storage Temperature Range	-55 to 150	°C
E _{AS}	Avalanche Energy, single pulse I _D = 54A, L = 0.1mH, R _G = 25Ω	146	mJ

(1) Typical $R_{\theta JA} = 41^{\circ}C/W$ on 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 0.06-inch (1.52-mm) thick FR4 PCB.

(2) Pulse duration \leq 300µs, duty cycle \leq 2%



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SLPS271G -JULY 2010-REVISED SEPTEMBER 2012

KAS TRUMENTS

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ELECTRICAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Cl	naracteristics					
BV _{DSS}	Drain to Source Voltage	$V_{GS} = 0V, I_{DS} = 250\mu A$	30			V
I _{DSS}	Drain to Source Leakage Current	$V_{GS} = 0V, V_{DS} = 24V$			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{DS} = 0V, V_{GS} = 20V$			100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}$, $I_{DS} = 250 \mu A$	1	1.5	2.1	V
Р	Drain to Source On Registeres	$V_{GS} = 4.5V, I_{DS} = 20A$		5.4	7.3	mΩ
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10V, I_{DS} = 20A$		4.1	5.2	mΩ
g _{fs}	Transconductance	$V_{DS} = 15V, I_{DS} = 20A$	59			S
Dynamic	Characteristics					
C _{iss}	Input Capacitance			960	1250	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 15V,$ f = 1MHz		630	820	pF
C _{rss}	Reverse Transfer Capacitance			51	66	pF
R _G	Series Gate Resistance			0.85	1.7	Ω
Qg	Gate Charge Total (4.5V)			6.4	8.3	nC
Q _{gd}	Gate Charge Gate to Drain			1.9		nC
Q _{gs}	Gate Charge Gate to Source	V _{DS} = 15V, I _{DS} = 20A		2.7		nC
Q _{g(th)}	Gate Charge at Vth			1.5		nC
Q _{oss}	Output Charge	$V_{DS} = 13.5V, V_{GS} = 0V$		16		nC
t _{d(on)}	Turn On Delay Time			7		ns
t _r	Rise Time	V _{DS} = 15V, V _{GS} = 4.5V,		11		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = 20A, R_G = 2\Omega$		9		ns
t _f	Fall Time			4.1		ns
Diode Cl	haracteristics					
V _{SD}	Diode Forward Voltage	$I_{SD} = 20A, V_{GS} = 0V$	0.85 1		1	V
Q _{rr}	Reverse Recovery Charge			25		nC
t _{rr}	Reverse Recovery Time	V_{DD} = 13.5V, I _F = 20A, di/dt = 300A/µs		24		ns

THERMAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

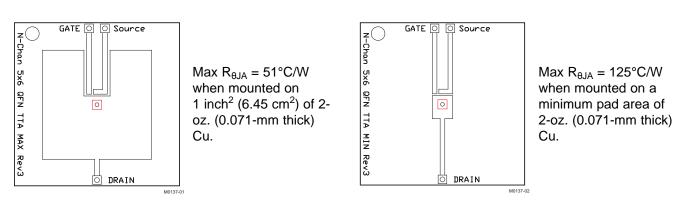
	PARAMETER	MIN	TYP	MAX	UNIT
$R_{ extsf{ heta}JC}$	Thermal Resistance Junction to Case ⁽¹⁾			1.6	°C/W
R_{\thetaJA}	Thermal Resistance Junction to Ambient ⁽¹⁾⁽²⁾			51	°C/W

(1) R_{θJC} is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch × 1.5-inch (3.81-cm × 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R_{θJC} is specified by design, whereas R_{θJA} is determined by the user's board design.
 (2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.



CSD17510Q5A

SLPS271G -JULY 2010-REVISED SEPTEMBER 2012



TYPICAL MOSFET CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

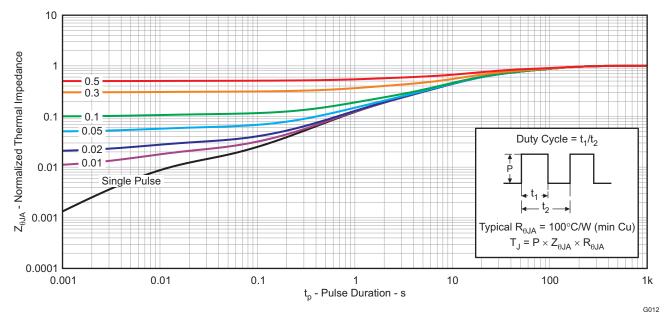


Figure 1. Transient Thermal Impedance

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TYPICAL MOSFET CHARACTERISTICS (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

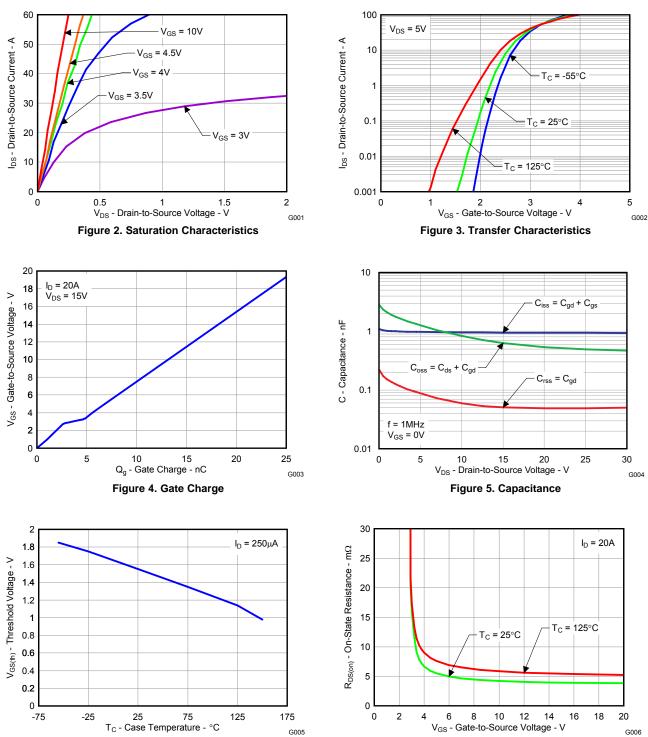


Figure 7. On-State Resistance vs. Gate-to-Source Voltage

Figure 6. Threshold Voltage vs. Temperature

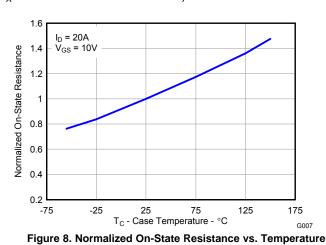


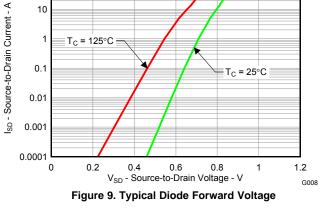
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TYPICAL MOSFET CHARACTERISTICS (continued)

100

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$





2000 1000 1ms 100ms - DC I_{DS} - Drain-to-Source Current - A 10ms . 1s 100 ┝┪╦╢ 10 1 0.1 Single Pulse Typical R_{thetaJA} =100°C/W(min Cu) 0.01 L 0.01

0.1

Figure 10. Maximum Safe Operating Area

V_{DS} - Drain-to-Source Voltage - V

1

10

50

G001

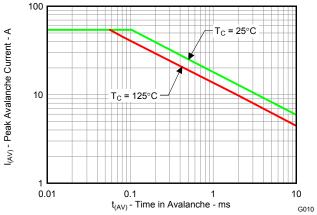


Figure 11. Single Pulse Unclamped Inductive Switching

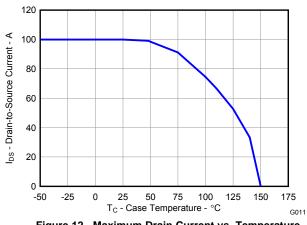
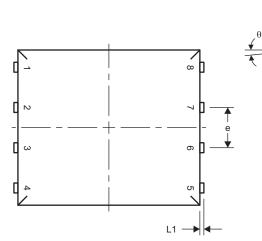


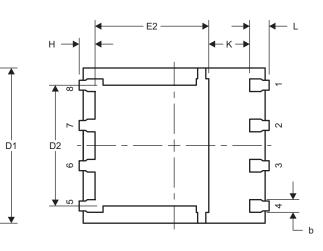
Figure 12. Maximum Drain Current vs. Temperature



MECHANICAL DATA

Q5A Package Dimensions

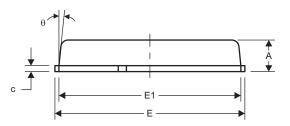




Bottom View

Top View

Side View



Front View

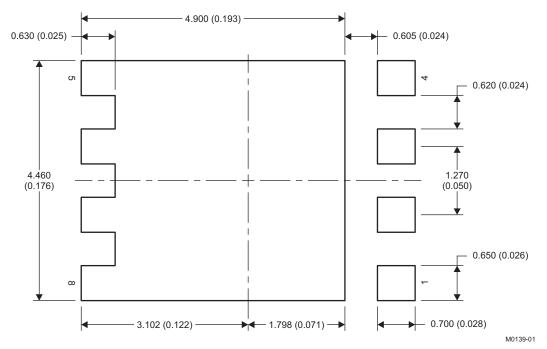
M0135-01

DIM	MILLIMETERS							
DIM	MIN	NOM	MAX					
A	0.90	1.00	1.10					
b	0.33	0.41	0.51					
С	0.20	0.25	0.34					
D1	4.80	4.90	5.00					
D2	3.61	3.81	4.02					
E	5.90	6.00	6.10					
E1	5.70	5.75	5.80					
E2	3.38	3.58	3.78					
e	1.17	1.27	1.37					
Н	0.41	0.56	0.71					
К	1.10							
L	0.51	0.61	0.71					
L1	0.06	0.13	0.20					
θ	0°		12°					



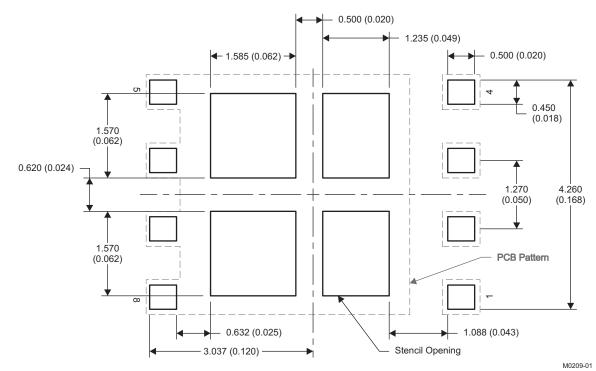
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Recommended PCB Pattern



NOTE: Dimensions are in mm (inches).

Stencil Recommendation



NOTE: Dimensions are in mm (inches).

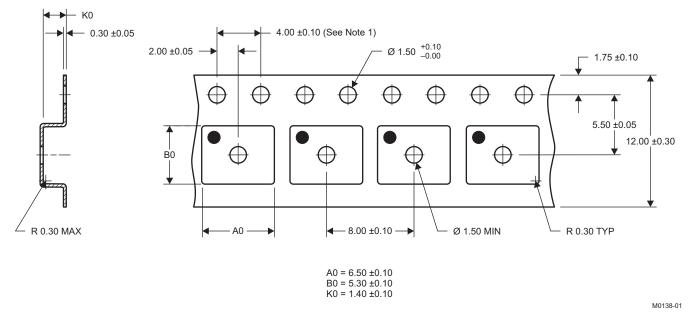
For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

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Q5A Tape and Reel Information



NOTES: 1. 10-sprocket hole-pitch cumulative tolerance ± 0.2

- 2. Camber not to exceed 1mm in 100mm, noncumulative over 250mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. A0 and B0 measured on a plane 0.3mm above the bottom of the pocket

REVISION HISTORY

Changes from Original (July 2010) to Revision A	Page
Changed the Y axis scale for Figure 5	4
Changes from Revision A (August 2010) to Revision B	Page
- Changed $R_{DS(on)}$ Test Conditions From V_{GS} = 8V To: V_{GS} = 10V	2
Changes from Revision B (September 2010) to Revision C	Page
Absolute Maximum Ratings, changed the E _{AS} value from 45 to 146 mJ	1
Changes from Revision C (September 2010) to Revision D	Page
Added the Stencil Recommendation section	
Changes from Revision D (November 2010) to Revision E	Page
 Changed V_{GS} in the Abs Max Ratings table From: +20/-12V To: ±20V Changed from +20/-12V to 20V 	



Changes from Revision F (October 2011) to Revision G

CSD17510Q5A

Page

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Changes from Revision E (July 2011) to Revision F				
•	Changed the I _D Continuous Drain Current, $T_c = 25^{\circ}C$ value From: 100 A To: 55 A.	1		
•	Changed Figure 10	5		
		-		

Changed Figure 10 5

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION

REEL DIMENSIONS

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TAPE AND REEL INFORMATION

TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD17510Q5A	SON	DQJ	8	2500	330.0	12.4	6.3	5.3	1.2	8.0	12.0	Q1
CSD17510Q5A	SON	DQJ	8	2500	330.2	12.4	6.5	5.3	1.4	8.0	12.0	Q1

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PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD17510Q5A	SON	DQJ	8	2500	340.0	340.0	38.0
CSD17510Q5A	SON	DQJ	8	2500	347.0	342.0	55.0

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